

STFU10NK60Z

N-channel 600 V, 0.68 Ω typ., 10 A, SuperMESH™ Power MOSFET in a TO-220FP ultra narrow leads package

Datasheet - production data

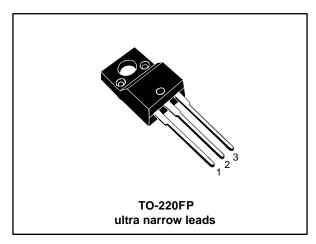
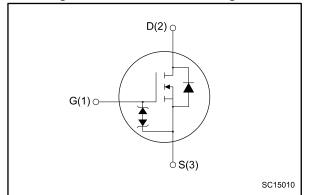


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ΙD	P _{tot}
STFU10NK60Z	600 V	0.75 Ω	10 A	35 W

- Extremely high dv/dt capability
- 100% avalanche tested
- · Gate charge minimized
- Zener-protected

Applications

Switching applications

Description

This high voltage device is a Zener-protected N-channel Power MOSFET developed using the SuperMESH™ technology by STMicroelectronics, an optimization of the well-established PowerMESH™. In addition to a significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

Table 1: Device summary

Order code	Marking	Package	Packaging
STFU10NK60Z	10NK60Z	TO-220FP ultra narrow leads	Tube

Contents STFU10NK60Z

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STFU10NK60Z Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	600	V
V_{GS}	Gate-source voltage	±30	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	10	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	5.7	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	36	Α
Ртот	Total dissipation at T _C = 25 °C	35	W
ESD	Gate-source, human body model (R = 1.5 k Ω , C = 100 pF)	4	kV
dv/dt ⁽³⁾	Peak diode recovery voltage slope	4.5	V/ns
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1s; T_{C} = 25 °C)	2500	V
Tj	Operation junction temperature range	55 to 150	Ç
T _{stg}	Storage temperature range	-55 to 150	J

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	3.6	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or non-repetitive (pulse width limited by T _J max)	10	Α
E _{AS}	Single pulse avalanche energy (starting T _J = 25 °C, I _D = I _{AR} , V _{DD} = 50 V)	300	mJ

⁽¹⁾Limited by package

⁽²⁾Pulse width limited by safe operating area

 $^{^{(3)}}I_{SD}$ < 10 A , di/dt < 200 A/ μs , V_{DD} = 80 % $V_{(BR)DSS}$

Electrical characteristics STFU10NK60Z

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 5: On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
	Zara gata valtaga drain	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			1	μΑ
IDSS	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V},$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	3	3.75	4.5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 4.5 A		0.68	0.75	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		ı	1370	ı	pF
Coss	Output capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V},$ $f = 1 \text{ MHz}$	1	156	1	pF
Crss	Reverse transfer capacitance	1 – 1 111112	1	37	ı	pF
Coss eq ⁽¹⁾	Equivalent output capacitance	V_{GS} = 0 V, V_{DS} = 0 to 480 V	ı	93	ı	pF
Qg	Total gate charge	$V_{DD} = 480 \text{ V}, I_D = 8 \text{ A},$	ı	48	1	nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V	ı	8	ı	nC
Q_{gd}	Gate-drain charge	(see Figure 13: "Test circuit for gate charge behavior")	1	25	1	nC

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 4 \text{ A},$	ı	20	-	ns
t _r	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$	-	20	-	ns
t _{d(off)}	Turn-off delay time	(see Figure 12: "Test circuit for resistive load switching	ı	55	-	ns
t _f	Fall time	times" and Figure 17: "Switching time waveform")	-	30	-	ns

 $^{^{(1)}}$ Defined by design, not subject to production test.

 $^{^{(1)}}$ Coss eq is defined as a constant equivalent capacitance giving the same charging time as Coss when Vps increases from 0 to 80%

Table 8: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} ⁽¹⁾	Source-drain current		-		10	V
I _{SDM} ⁽²⁾	Source-drain current (pulsed)		-		36	Α
V _{SD} ⁽³⁾	Forward on voltage	I _{SD} = 10 A, V _{GS} = 0 V	ı		1.6	V
t _{rr}	Reverse recovery time	I _{SD} = 8 A, di/dt = 100 A/µs,	-	570		ns
Qrr	Reverse recovery charge	$V_{DD} = 40 \text{ V}$, $T_J = 150 \text{ °C}$	-	4.1		μC
I _{RRM}	Reverse recovery current	(see Figure 14: "Test circuit for inductive load switching and diode recovery times")	-	15		А

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	±30	-	-	V

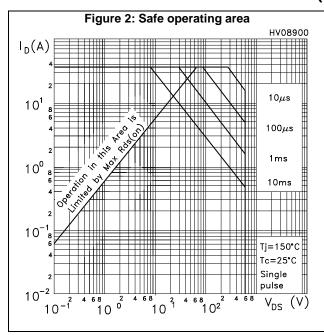
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

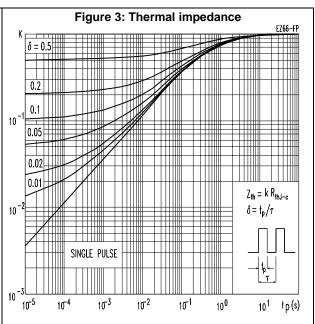
⁽¹⁾Limited by package

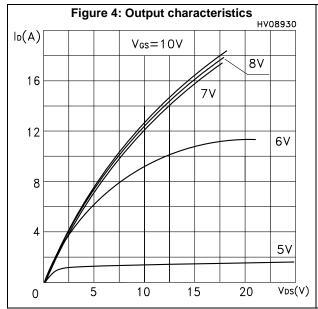
⁽²⁾Pulse width limited by safe operating area

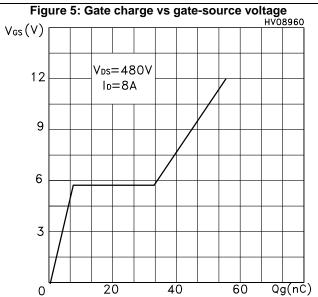
 $^{^{(3)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

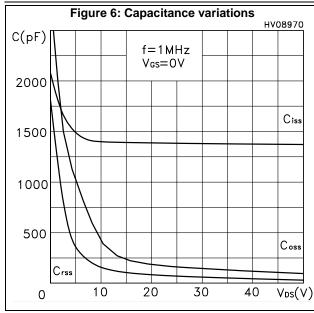
2.1 Electrical characteristics (curves)











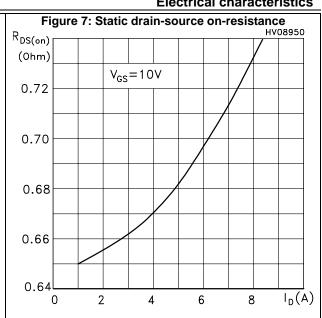
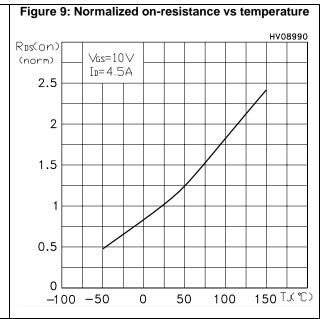
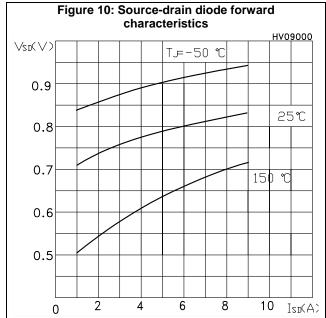
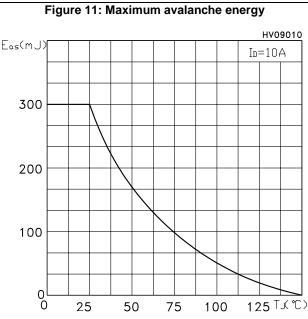


Figure 8: Normalized gate threshold voltage vs temperature HV08980 Vas(th) $\bigvee_{DS} = \bigvee_{GS}$ (norm) ID=250 µA 1.1 1 0.9 0.8 0.7 0.6 150 T⊀℃> -100 **-**50 0 50 100







STFU10NK60Z Test circuits

3 Test circuits

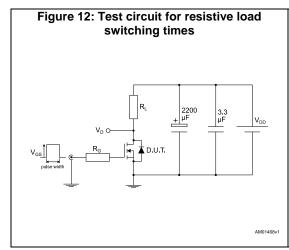


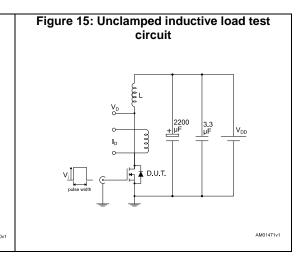
Figure 13: Test circuit for gate charge behavior

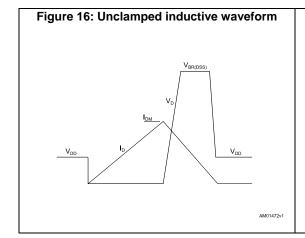
12 V 47 KΩ 100 NF D.U.T.

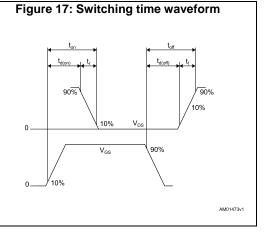
2200 PF 47 KΩ OVG

AM01466y1

Figure 14: Test circuit for inductive load switching and diode recovery times







4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220FP ultra narrow leads package information

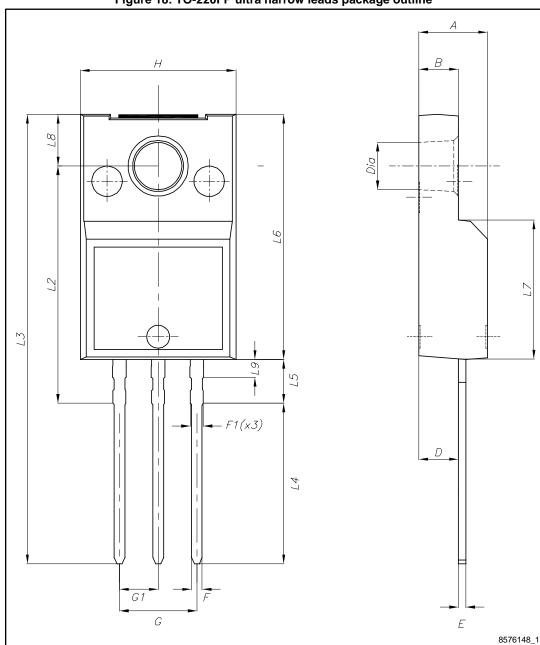


Figure 18: TO-220FP ultra narrow leads package outline

Table 10: TO-220FP ultra narrow leads mechanical data

Dim	mm				
Dim.	Min.	Тур.	Max.		
А	4.40		4.60		
В	2.50		2.70		
D	2.50		2.75		
Е	0.45		0.60		
F	0.65		0.75		
F1	-		0.90		
G	4.95		5.20		
G1	2.40	2.54	2.70		
Н	10.00		10.40		
L2	15.10		15.90		
L3	28.50		30.50		
L4	10.20		11.00		
L5	2.50		3.10		
L6	15.60		16.40		
L7	9.00		9.30		
L8	3.20		3.60		
L9	-		1.30		
Dia.	3.00		3.20		

Revision history STFU10NK60Z

5 Revision history

12/13

Table 11: Document revision history

Date	Revision	Changes
07-Jan-2016	1	Initial release.
12-Sep-2016	2	Document status changed from preliminary to production data. Minor text changes.
05-Dec-2016	3	Updated Features on cover page. Updated Table 2: "Absolute maximum ratings" and added Table 4: "Avalanche characteristics". Updated Table 5: "On /off states", Table 6: "Dynamic", Table 8: "Source drain diode" and Table 9: "Gate-source Zener diode". Minor text changes

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